

Notice of References Cited

 Application/Control No.
 10/054,514

 Applicant(s)/Patent Under.
 Reexamination
 STELTER ET AL.

 Examiner
 Mark A. Chapman

 Art Unit
 1756

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0022190	02-2002	Iizuka et al.	430/110.4
	B	US-5,866,289	02-1999	Asanae et al.	430/111.41
	C	US-3,895,125	07-1975	Tsuchiya et al.	430/122
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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